Search Notes			

Application/Control No.	Applicant(s)/Patent under Reexamination	•
10/596,590	ONOUE ET AL.	
Examiner	Art Unit	
Karuna P. Reddy	1796	

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Class	Subclass	Date	Examiner
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARCH	)TES I STRATEGY)	)
	DATE	EXMR
EAST, Inventor's Search	12/14/2007	KR